

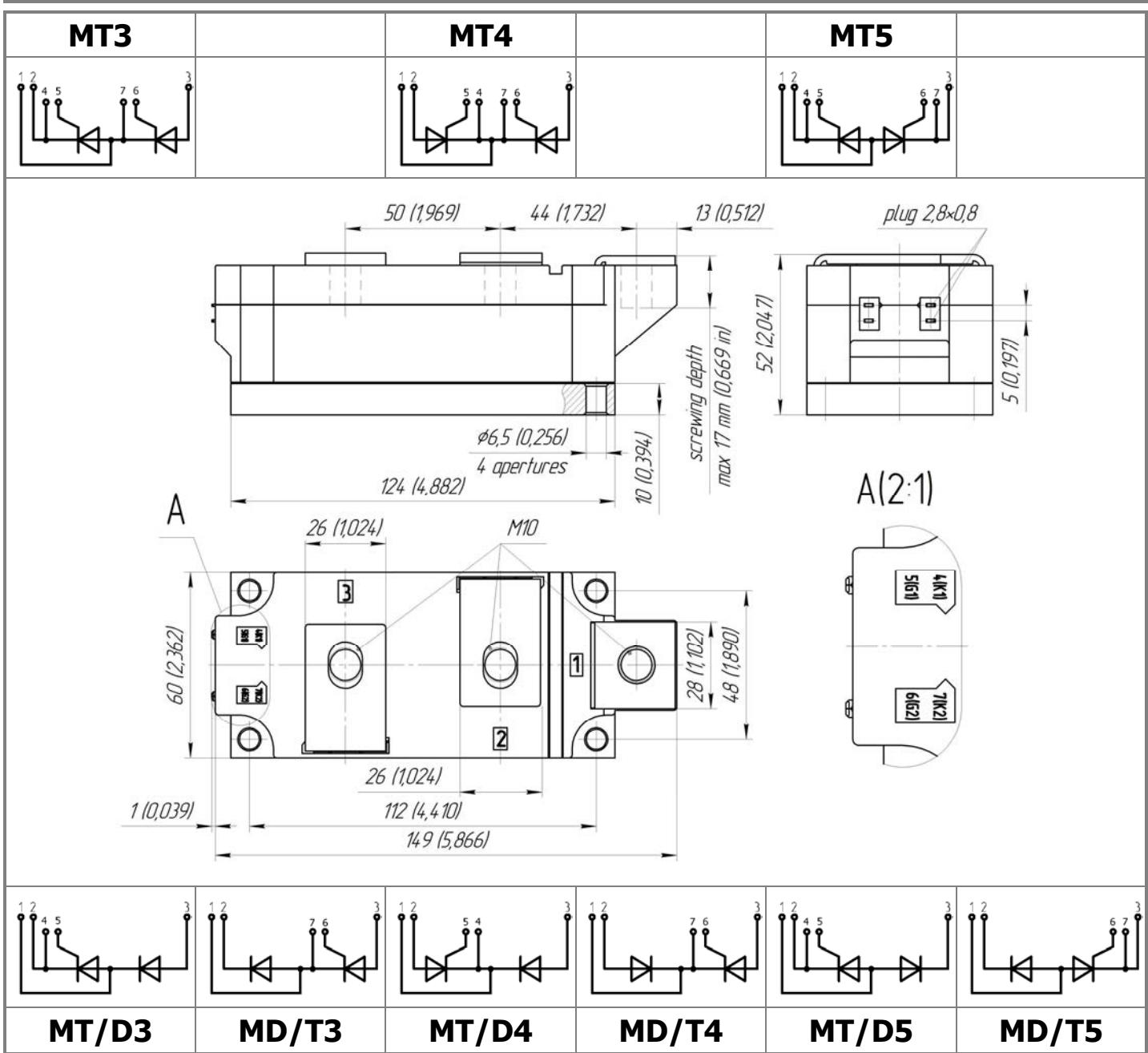


# Thyristor / Diode Modules

## MT/Dx-540-18-A2, MD/Tx-540-18-A2



Mean on-state current	I <sub>TAV</sub>	540 A	
Repetitive peak off-state voltage	V <sub>DRM</sub>	1400 ÷ 1800 V	
Repetitive peak reverse voltage	V <sub>RRM</sub>		
Turn-off time	t <sub>q</sub>	250 µs	
V <sub>DRM</sub> , V <sub>RRM</sub> , V	1400	1600	1800
Voltage code	14	16	18
T <sub>j</sub> , °C	- 40 ÷ 130		



## MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions	
<b>ON-STATE</b>					
I <sub>TAV</sub>	Mean on-state current	A	540	$T_c=85^\circ\text{C}$ ;	
I <sub>TRMS</sub>	RMS on-state current	A	845	$180^\circ$ half-sine wave; 50 Hz	
I <sub>TSM</sub>	Surge on-state current	kA	15.5 18.0	$T_j=T_{j\max}$ $T_j=25^\circ\text{C}$	$180^\circ$ half-sine wave; 50 Hz ( $t_p=10$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=2$ A; $t_{GP}=50$ $\mu\text{s}$ ; $di_G/dt \geq 1$ A/ $\mu\text{s}$
			17.0 20.0	$T_j=T_{j\max}$ $T_j=25^\circ\text{C}$	$180^\circ$ half-sine wave; 60 Hz ( $t_p=8.3$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=2$ A; $t_{GP}=50$ $\mu\text{s}$ ; $di_G/dt \geq 1$ A/ $\mu\text{s}$
I <sup>2</sup> t	Safety factor	$\text{A}^2\text{s} \cdot 10^3$	1200 1620	$T_j=T_{j\max}$ $T_j=25^\circ\text{C}$	$180^\circ$ half-sine wave; 50 Hz ( $t_p=10$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=2$ A; $t_{GP}=50$ $\mu\text{s}$ ; $di_G/dt \geq 1$ A/ $\mu\text{s}$
			1195 1660	$T_j=T_{j\max}$ $T_j=25^\circ\text{C}$	$180^\circ$ half-sine wave; 60 Hz ( $t_p=8.3$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=2$ A; $t_{GP}=50$ $\mu\text{s}$ ; $di_G/dt \geq 1$ A/ $\mu\text{s}$
<b>BLOCKING</b>					
V <sub>DRM</sub> , V <sub>RRM</sub>	Repetitive peak off-state and Repetitive peak reverse voltages	V	1400÷1800	$T_{j\min} < T_j < T_{j\max}$ ; $180^\circ$ half-sine wave; 50 Hz; Gate open	
V <sub>DSM</sub> , V <sub>RSM</sub>	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	1500÷1900	$T_{j\min} < T_j < T_{j\max}$ ; $180^\circ$ half-sine wave; 50 Hz; single pulse; Gate open	
V <sub>D</sub> , V <sub>R</sub>	Direct off-state and Direct reverse voltages	V	$0.75 \cdot V_{DRM}$ $0.75 \cdot V_{RRM}$	$T_j=T_{j\max}$ ; Gate open	
<b>TRIGGERING</b>					
I <sub>FGM</sub>	Peak forward gate current	A	8	$T_j=T_{j\max}$	
V <sub>RGM</sub>	Peak reverse gate voltage	V	5		
P <sub>G</sub>	Gate power dissipation	W	4	$T_j=T_{j\max}$ for DC gate current	
<b>SWITCHING</b>					
(di <sub>T</sub> /dt) <sub>crit</sub>	Critical rate of rise of on-state current non-repetitive ( $f=1$ Hz)	A/ $\mu\text{s}$	400	$T_j=T_{j\max}$ ; $V_D=0.67 \cdot V_{DRM}$ ; $I_{TM}=2 I_{TAV}$ ; Gate pulse: $I_G=2$ A; $t_{GP}=50$ $\mu\text{s}$ ; $di_G/dt \geq 1$ A/ $\mu\text{s}$	
<b>THERMAL</b>					
T <sub>stg</sub>	Storage temperature	°C	-40 ÷ 125		
T <sub>j</sub>	Operating junction temperature	°C	-40 ÷ 130		
<b>MECHANICAL</b>					
a	Acceleration under vibration	m/s <sup>2</sup>	50		

## CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions
<b>ON-STATE</b>				
$V_{TM}$	Peak on-state voltage, max	V	1.50	$T_j=25\text{ }^\circ\text{C}; I_{TM}=1570\text{ A}$
$V_{T(TO)}$	On-state threshold voltage, max	V	0.85	$T_j=T_{j\max}$ ;
$r_T$	On-state slope resistance, max	$\text{m}\Omega$	0.320	$0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$
$I_L$	Latching current, max	mA	1000	$T_j=25\text{ }^\circ\text{C}; V_D=12\text{ V};$ Gate pulse: $I_G=2\text{ A}$ ; $t_{GP}=50\text{ }\mu\text{s}; di_G/dt \geq 1\text{ A}/\mu\text{s}$
$I_H$	Holding current, max	mA	300	$T_j=25\text{ }^\circ\text{C};$ $V_D=12\text{ V};$ Gate open
<b>BLOCKING</b>				
$I_{DRM}, I_{RRM}$	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	70	$T_j=T_{j\max}$ ; $V_D=V_{DRM}; V_R=V_{RRM}$
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage, min	$\text{V}/\mu\text{s}$	1000	$T_j=T_{j\max}$ ; $V_D=0.67V_{DRM};$ Gate open
<b>TRIGGERING</b>				
$V_{GT}$	Gate trigger direct voltage, max	V	4.00 2.50 2.00	$T_j=T_{j\min}$ $T_j=25\text{ }^\circ\text{C}$ $T_j=T_{j\max}$
$I_{GT}$	Gate trigger direct current, max	mA	400 250 200	$T_j=T_{j\min}$ $T_j=25\text{ }^\circ\text{C}$ $T_j=T_{j\max}$
$V_{GD}$	Gate non-trigger direct voltage, min	V	0.25	$T_j=T_{j\max}$ ; $V_D=0.67V_{DRM};$
$I_{GD}$	Gate non-trigger direct current, min	mA	10.00	Direct gate current
<b>SWITCHING</b>				
$t_{gd}$	Delay time	$\mu\text{s}$	2.00	$T_j=25\text{ }^\circ\text{C}; V_D=0.4V_{DRM}; I_{TM}=I_{TAV};$ Gate pulse: $I_G=2\text{ A}$ ; $t_{GP}=50\text{ }\mu\text{s}; di_G/dt \geq 1\text{ A}/\mu\text{s}$
$t_q$	Turn-off time, max	$\mu\text{s}$	250	$dv_D/dt=50\text{ V}/\mu\text{s}; T_j=T_{j\max}; I_{TM}=I_{TAV};$ $di_R/dt=10\text{ A}/\mu\text{s}; V_R=100\text{ V};$ $V_D=0.67V_{DRM};$
<b>THERMAL</b>				
$R_{thjc}$	Thermal resistance, junction to case			
	per module	$^\circ\text{C}/\text{W}$	0.0325	180° half-sine wave, 50 Hz
	per arm	$^\circ\text{C}/\text{W}$	0.0650	
	per module	$^\circ\text{C}/\text{W}$	0.0310	DC
	per arm	$^\circ\text{C}/\text{W}$	0.0620	
$R_{thch}$	Thermal resistance, case to heatsink			
	per module	$^\circ\text{C}/\text{W}$	0.0100	
	per arm	$^\circ\text{C}/\text{W}$	0.0200	
<b>INSULATION</b>				
$V_{ISOL}$	Insulation test voltage	kV	3.00	Sine wave, 50 Hz; $t=1\text{ min}$
			3.60	RMS $t=1\text{ sec}$
<b>MECHANICAL</b>				
$M_1$	Mounting torque (M6) <sup>1)</sup>	Nm	6.00	Tolerance $\pm 15\%$
$M_2$	Terminal connection torque (M10) <sup>1)</sup>	Nm	12.00	Tolerance $\pm 15\%$
w	Weight	g	1500	

PART NUMBERING GUIDE	NOTES
MT    3    -    540    -    18    -    A2    -    N 1      2            3            4            5            6 1. Thyristor module (MT) Thyristor – Diode module (MT/D) Diode – Thyristor module (MD/T) 2. Circuit Schematic: 3 – serial connection 4 – common Cathode 5 – common Anode 3. Average On-state Current, A 4. Voltage Code 5. Package Type (M.A2) 6. Ambient Conditions: N – Normal	1) The screws must be lubricated